

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	§	
Schlichting	§	
	§	Group Art Unit: Unassigned
Serial No.: Unassigned	§	
	§	
Confirmation No.: Unassigned	§	
	§	Examiner: Unassigned
Filed: Herewith	§	
	§	
For: Charged Particle Beam	§	
Device for Inspecting or	§	
Structuring a Specimen	§	

MAIL STOP PATENT APPLICATION
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

CERTIFICATE UNDER 37 CFR 1.10	
I hereby certify that this correspondence and the documents referred to as attached therein are being deposited on January 14, 2004 with the United States Postal Service in an envelope as "Express Mail Post Office to Addressee," mailing label No. EV 321682682 US addressed to: Box Patent Application, Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.	
Date 1/14/04	Signature B. Todd Patterson

Dear Sir:

INFORMATION DISCLOSURE STATEMENT

The Applicants, and the Attorney who signs below on the basis of the information supplied by the inventor and the information in his file, submit herewith patents, publications, or other information of which they are aware, which may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

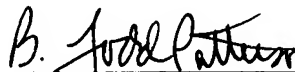
While the information submitted in this Information Disclosure Statement may be material pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that any patent, publication, or other information referred to therein is prior art for this invention unless specifically designated as such.

In accordance with 37 CFR § 1.97, this Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possibly material information as defined under 37 CFR § 1.56(a) exists.

The patents and/or publications submitted herewith are set forth on the attached Form PTO-1449.

If the sum of \$180.00 is due under 37 CFR § 1.17(p) pursuant to § 1.97, the Commissioner is hereby authorized to charge this fee, and any other fee necessary to make this submission timely, to the Deposit Account No. 20-0782/ZIMR/0008/BTP.

Respectfully submitted,



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U.S. Department of Commerce, Patent and Trademark Office		Docket No.	Serial No.
(PTO Form 1449 modified)		ZIMR/0008	Unassigned
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant Schlichting	Confirmation No.: Unassigned
(Use several sheets if necessary)		Filing Date	Group
	Examiner	Uassigned	Herewith
			Unassigned

U.S. Patent Documents

*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
	A1	6,066,849	05/23/00	Masnaghetti, et al.	250	310	09/08/98
	A2	5,139,624	08/18/92	Searson, et al.	204	129.3	12/06/90
	A3						
	A4						
	A5						
	A6						
	A7						
	A8						
	A9						
	A10						
	A11						
	A12						
	A13						

Foreign Patent Documents

*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
	B1	1 047 104 A1	10/25/00	EP	H01j	37/305	<input type="checkbox"/>	<input type="checkbox"/>
	B2	0 969 494 A1	01/05/00	EP	H10j	37/02	<input type="checkbox"/>	<input type="checkbox"/>
	B3						<input type="checkbox"/>	<input type="checkbox"/>
	B4						<input type="checkbox"/>	<input type="checkbox"/>
	B5						<input type="checkbox"/>	<input type="checkbox"/>

OTHER ART

*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C1	Frosien, <i>et al.</i> , "High Precision Electron Optical System for Absolute and CD-measurements on Large Substrates," Nuclear Instruments and Methods in Physics Research A 363 (1995) 25-30
	C2	European Search Report, dated July 4, 2003 for EP 03000677.9
	C3	

Examiner

Date Considered

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.